

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/617,335	LEE ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Thuy V. Tran	2821	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,504,315	01-2003	Kim, Dae-Bong	315/224
*	B	US-5,801,492	09-1998	Bobel, Andrzej	315/244
*	C	US-5,404,082	04-1995	Hernandez et al.	315/219
*	D	US-5,068,576	11-1991	Hu et al.	315/291
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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